

**Notice of References Cited**

Application/Control No.

10/675,986

Applicant(s)/Patent Under

Reexamination

LEE ET AL.

Examiner

YOUNG T. TSE

Art Unit

2611

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,253,268 A	10-1993	Omura et al.	375/150
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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